




<p style="text-align: center;">Searched</p> 	<p>Application/Control No.</p> <p>10747790</p>	<p>Applicant(s)/Patent Under Reexamination</p> <p>FEHR, WALTON</p>
	<p>Examiner</p> <p>Kaplan, Hal I</p>	<p>Art Unit</p> <p>2836</p>

Class	SubClass	Date	Examiner
307	9.1	10/13/2006	HK
307	23	10/13/2006	HK
307	29	10/13/2006	HK
307	80	10/13/2006	HK
307	82	10/13/2006	HK

U.S. Patent and Trademark Office	Part of Paper No.: 20061013
----------------------------------	-----------------------------

Search Notes 	Application/Control No. 10747790	Applicant(s)/Patent Under Reexamination FEHR, WALTON
	Examiner Kaplan, Hal I	Art Unit 2836

Notes	Date	Examiner
307/23,29,80,82 (consulted Robert DeBeradinis)	05/25/2006	HK
710/\$ (no search), 713/323,324 (consulted Fritz Fleming)	05/25/2006	HK
EAST (US-PGPUB,USPAT,USOCR,FPRS,EPO,JPO,DERWENT,IBM_TD B) - See Search History Printout	10/13/2006	HK
U.S. Patent and Trademark Office		Part of Paper No.: 20061013

Interference Searched 	Application/Control No. 10747790	Applicant(s)/Patent Under Reexamination FEHR, WALTON
	Examiner Kaplan, Hal I	Art Unit 2836

Class	SubClass	Date	Examiner
Interference Search History Printout		10/13/2006	HK
U.S. Patent and Trademark Office		Part of Paper No.:	20061013